TEST REPORT

Electromagnetic Compatibility

Report Reference No. ..... :	**463969-3TRFEMC**
Date of issue ..... :	2022-05-13
Test Report Verdict ..... :	PASS
Testing Laboratory..... :	**Nemko S.p.A.**
Address..... :	Via Del Carroccio, 4
City ..... :	20853 Biassono (MB)
Country ..... :	Italy
Testing location..... :	Described at clause 1.4
Customer name..... :	**Nextys SA**
Customer contact information .... :	Via Luserte Sud, 6 – 6572 Quartino – Switzerland
Reference standards..... :	**IEC 61000-6-2:2016 – IEC 61000-6-3:2020** **EN IEC 61000-6-2:2019 – EN IEC 61000-6-3:2021**
Standard application ..... :	Full application
Equipment under test ..... :	**DIN rail power supply**
Trademark(s) ..... :	--
Manufacturer..... :	Nextys SA
Model/Type reference ..... :	Described at clause 4.1
Tests performed by ..... :	G.Tepelena
Report approved by..... :	D. Guarnone

CONTENTS

1. GENERAL INFORMATION

1.1 Project history

Report number	Modification to the report / comments	Date
463969-3TRFEMC	First release	2022-05-13
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1.2 Symbol used in the report

☒ ..... :	The crossed square indicates that the listed condition, standard or equipment is applicable for this report.
☐ ..... :	The empty square indicates that the listed condition, standard or equipment is not applicable for this report.
NP (Not performed)..... :	Test case not performed according to customer request
N (Not applicable) ..... :	Test case does not apply to the test object
P (Pass)..... :	Test object does meet the requirement
F (Fail) ..... :	Test object does not meet the requirement
☐ Comma (,) / ☒ Dot (.) ..... :	Symbol used as decimal separator throughout this report
Asterisk (*)	Symbol not used throughout this report
EUT ..... :	Equipment Under Test

The results contained in this report reflect the results for this particular model(s) and serial number(s) and apply to the sample(s) as received. It is the responsibility of the manufacturer to ensure that all production models meet the intent of the requirements detailed within this report.

1.3 Date of sample(s) reception and tests

Date of receipt of test sample(s) .....:	2022-05-12
Testing start date .....:	2022-05-12
Testing termination date .....:	2022-05-13

1.4 Testing location

The tests have been performed in the place indicated below:	
☒ Nemko premises location .....:	Nemko S.p.A.
	Via Del Carroccio, 4
	20853 Biassono (MB) - Italy
☐ Other location .....:	--
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1.5 Environmental conditions

The tests were carried out in the ranges of environmental conditions specified below:	
Ambient temperature .....:	18-33 °C [1]
Relative Humidity .....:	25-70 % [2]
Atmospheric pressure .....:	860-1060 hPa

Notes:
[1] For luminaire, temperature during tests was verified to be within 18 ÷ 30 °C
[2] During ESD test, humidity was verified to be within 30 ÷ 60 %

The following instruments are used to monitor the environmental conditions:

Equipment	Trademark	Model	Serial No.
Thermo-hygrometer	Testo	175-H2	20012380/305
Thermo-hygrometer	Testo	175-H2	38203337/703
Barometer	Castle	GPB 3300	072015

1.6 Measurement uncertainty and assessment of conformity

The measurement uncertainty was calculated for each test and quantity listed in this test report, according to CISPR 16-4-2 and other specific test standard and is documented in Nemko Spa working manual WML1002. The assessment of conformity for each test performed on the equipment is performed not taking into account the measurement uncertainty. The two following possible verdicts are stated in the report:

P (Pass) - The measured values of the equipment respect the specification limit at the points tested. The specific risk of false accept is up to 50% when the measured result is close to the limit.

F (Fail) - One or more measured values of the equipment do not respect the specification limit at the points tested. The specific risk of false reject is up to 50% when the measured result is close to the limit.

Hereafter Nemko's measurement uncertainties are reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Disturbance	Antenna distance 1 m, 3 m, 10 m 0.009 ÷ 200 MHz	5.0 dB	(1)
	Antenna distance 1 m, 3 m, 10 m 200 ÷ 1000 MHz	5.2 dB	(1)
	Antenna distance 1 m, 3 m, 10 m 1 ÷ 6 GHz	5.2 dB	(1)
	Antenna distance 1 m, 3 m 6 ÷ 18 GHz	5.5 dB	(1)
	Antenna distance 1 m, 3 m 18 ÷ 40 GHz	7.2 dB	(1)
Radiated Disturbance with large loop antenna system (LLAS)	0.009 ÷ 30 MHz	3.3 dB	(1)
Conducted Disturbance	0.02 ÷ 150 kHz with AMN	3.8 dB	(1)
	150 kHz ÷ 30 MHz with AMN	3.4 dB	(1)
	150 kHz ÷ 30 MHz with AAN	4.6 dB	(1)
	9 kHz ÷ 30 MHz with voltage probe	2.9 dB	(1)
	150 kHz ÷ 30 MHz with current probe	2.9 dB	(1)
Clicks	9 ÷ 150 kHz	3.8 dB	(1)
	150 kHz ÷ 30 MHz	3.4 dB	(1)
Disturbance Power	30 MHz ÷300 MHz	4.5 dB	(1)
Frequency	10 Hz ÷ 1 kHz	0.2 %	(1)
	1 kHz ÷ 40 GHz	10^{-6}	(1)
Harmonic Current Emission	50 Hz ÷ 2 kHz	3 %	(1)
Fluctuation and Flikers	Fluctuation (d%)	0.05 %	(1)
	Flikers (Pst)	5 %	(1)
Radiated Immunity Anechoic Chambers	20 MHz ÷ 6 GHz	3.4 dB	(1) (3)
Radiated Immunity TEM Cell	0.01 ÷ 200 MHz	3.0 dB	(1) (3)
Bulk Current	0.1 ÷ 400 MHz	3.0 dB	(1)
Immunity to conducted disturbances	9 kHz ÷ 230 MHz	3.0 dB	(1)
ESD Immunity	Voltage, Current, Rise time, Duration	(2)	(1)
Burst Immunity	Voltage, frequency, burst period and duration, rise time and pulse width	(2)	(1)
Surge Immunity	Voltage, Current, Rise time, Duration	(2)	(1)
DIPS, Interruption and Voltage duration Immunity	Amplitude	5 %	(1)
	Duration	5 %	
Impulse Magnetic Field Immunity	Peak Current	10 %	(1) (3)
	Rise time, Duration	20 %	
Power Frequency Magnetic Field Immunity	16.7 Hz, 50 Hz, 60 Hz	2.0 dB	(1) (3)
Damped Oscillatory Wave Immunity, Ring Wave Immunity	Voltage, front time, frequency 100 kHz, 1 MHz	(2)	(1)
Damped Magnetic Field	Amplitude: 100 kHz, 1 MHz	3 dB	(1)
	Frequency: 100 kHz, 1 MHz	10 %	
Low Frequency Immunity	15 Hz ÷ 150 kHz	2.2 dB	(1)
Automotive transients Immunity	Voltage, rise time, duration time Impulses 1, 2a, 2b, 3a, 3b and 4	(2)	(1)
Automotive transients Emission	Amplitude, Time	10 %	(1)
EMF for Lighting Equipment	-	25 %	(1)
Electromagnetic fields (EMF)	Magnetic, Electric and Electromagnetic fields: 0 Hz ÷ 40 GHz	25 %	(1)
Electrical quantities (voltage, current, resistance)	AC/DC Voltage 10 mV ÷ 1000 V 0÷100 kHz AC/DC Current 0.1 mA ÷ 400 A 0÷1 kHz Resistance 100 mΩ ÷ 10 MΩ	2.5 %	(1)

NOTES:

(1) The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k = 2, which for a normal distribution corresponds to a coverage probability of approximately 95 %

(2) The instruments used for this immunity test is according to the tolerances requested by the applicable standard

(3) The reported expanded uncertainty of measurement is related to the stimulus quantity

1.7 Instruments calibration table

Instrument cited in the report and not listed in this paragraph are not subject to calibration. The calibration is valid up to the last day of the due date month.

Description	Manufacturer	Model	Identifier	Cal Date	Due Date
EMI Receiver	Rohde & Schwarz	ESW44	101620	2021-08	2022-08
EMI Receiver	Rohde & Schwarz	ESU8	100202	2021-09	2022-09
Antenna Trilog 25MHz - 8GHz	Schwarzbeck Mess-Elektronik	VULB9162	9162-025	2021-07	2024-07
Antenna Trilog 25-2000 MHz	Schwarzbeck Mess-Elektronik	VULB9168	9168-242	2021-06	2024-06
Antenna 1 - 18 GHz	Schwarzbeck Mess-Elektronik	STLP9148	STLP 9148-152	2021-09	2024-09
Antenna 1 - 18 GHz	Schwarzbeck Mess-Elektronik	STLP9148	STPL 9148-123	2021-06	2024-06
Broadband Amplifier	Schwarzbeck Mess-Elektronik	BBV9718C	00121	2022-01	2023-01
Preamplifier	Schwarzbeck Mess-Elektronik	BBV9718	BBV9718-137	2021-04	2022-04
Semi-anechoic chamber	Nemko S.p.a.	10m semi-anechoic chamber	530	2021-09	2023-09
Common Mode Absorption Device	Schwarzbeck Mess-Elektronik	CMAD1614	00041	2021-05	2022-05
LISN	Rohde & Schwarz	ESH2-Z5	881 362/006	2022-03	2023-03
LISN	Rohde & Schwarz	ESH2-Z5	872 460/041	2021-09	2022-09
V-network	Rohde & Schwarz	ESH3-Z5	840 731/004	2021-09	2022-09
Voltage probe	Rohrbacher	VP-1	2.455	2021-09	2022-09
RF Current Probe	Rohde & Schwarz	ESH2-Z1	891 923/18	2020-09	2023-09
Impedance stabilization network	Teseq	ISN T800	47263	2021-08	2024-08
Impedance Stabilisation Network	Schwarzbeck Mess-Elektronik	NTFM8131	8131-153	2021-05	2022-05
Absorbing clamp	Rohde & Schwarz	MDS-21	893 169/001	2021-09	2022-09
Absorbing clamp	Rohde & Schwarz	MDS-21	893 169/003	2021-09	2022-09
Harmonics and Flicker analyzer	Emc Partner	HARMONICS1000+HAR-EXT1000	016+103489	2021-11	2022-11
Harmonics and Flicker analyzer	EM Test	DPA500N	P1735202736	2022-03	2023-03
AC Power Source	Elettrotest	TPS/M/6000	358 04/18	2022-03	2023-03
Attenuator	Aeroflex / Weinschel	2	CC8577	2021-07	2022-07
Attenuator	Aeroflex / Weinschel	2	CC8577	2021-07	2022-07
ESD Simulator	Emc Partner	ESD3000+DM1	252+192	2021-10	2022-10

Description	Manufacturer	Model	Identifier	Cal Date	Due Date
ESD Simulator + Coupling Network	Teseq	NSG437	767+437767+661+695+445 +1190	2022-04	2023-04
Broadband amplifier	Rohde & Schwarz	BBA100	101163	2021-09	2022-09
Broadband Amplifier	Rohde & Schwarz	BBA150	102626	2021-09	2022-09
RF Amplifier 200MHz-1000MHz	IFI	CMX100010-SMCC1000	L448A-0108	2022-02	2023-02
RF Amplifier 0,8-4,2 GHz	Amplifier Research	50S1G4A	301049	2021-05	2022-05
RF Power Sensor	Rohde & Schwarz	NRP18AN	100990	2022-01	2023-01
RF Power Sensor	Rohde & Schwarz	NRP18AN	100987	2021-09	2022-09
RF Signal Generator	Rohde & Schwarz	SMB100A	180431	2021-09	2022-09
RF Signal Generator	Rohde & Schwarz	SMA100B	104075	2021-07	2022-07
Antenna	Amplifier Research	AT6026A	0330876	2019-11	2022-11
Antenna Biconilog	ETS Lindgren	3142E	00213197	2019-11	2022-11
Broad-Band Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA9120D	01874	2021-02	2024-02
EMC Multifunction Instrument+CDN Triphase 32A+CDN for I/O	Emc Partner	IMU3000+CDN2000-06-32+CDN-UTP ED3	F5-S-D-V-1505+CDN2000-06-30-1537+CDN-UTP ED3-1526	2022-04	2023-04
EMC Multifunction Instrument+CDN Triphase Burst+CDN Surge	Emc Partner+Schaffner	Transient2000+CDN300+CDN116	849+231+149 9318	2021-09	2022-09
Coupling clamp	Schaffner	CDN125	245 9219	2022-04	2023-04
Capacitive Coupling clamp	Emc Partner	CDN	CNEFT1000-120	2022-04	2023-04
Power supply	Zenone	GVS300GL	0000000444	2021-07	2022-07
Power supply	Zenone	GVS300GL	0000000445	2021-07	2022-07
Power supply	Zenone	GVS300GL	0000000446	2021-07	2022-07
H/E Fieldmeter	Maschek	ESM-100	971909-G	2022-01	2023-01
Automotive EMC pulse generator	EM Test	UCS 200N	V1239113698	2021-09	2022-09
V-network	Rohde & Schwarz	ESH3-Z6	843 864/025	2021-09	2022-09
V-network	Rohde & Schwarz	ESH3-Z6	843 864/024	2021-10	2022-10
V-network	Rohde & Schwarz	ESH3-Z6	893 046/010	2021-07	2022-07
V-network	Rohde & Schwarz	ESH3-Z6	843 864/026	2021-09	2022-09

Description	Manufacturer	Model	Identifier	Cal Date	Due Date
Test System for Conducted and Radiated Immunity	Teseq - Ametek	NSG4070C-80	540125	2021-09	2022-09
EM Injection Clamp	Fisher Custom Communications Inc	F-203I-23mm	121239	2021-11	2022-11
Bulk current injection probe	Fisher Custom Communications Inc	F-120-9A	447	2021-09	2022-09
Attenuator + Coaxial cable	EM Test + Huber+Shuner	ATT6+CS03+CS04+CS05	0206-18+1.662+1.663+1.664	2021-09	2022-09
Coupling/Decoupling Network	Luthi	CDN AF2	P1425135039	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN M1	P1422134545	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN M2/M3	P1426135614	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN M4 N-32A	P1343125190	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN M4 PE-32A	P1428136828	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN M5-32A	P1430137446	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN S1-50 BNC	P1430137436	2021-11	2022-11
Coupling/Decoupling Network	Luthi	CDN T2	P1427136163	2021-11	2022-11
Coupling/Decoupling Network	EM Test	CDN M2/M3	0307-16	2021-11	2022-11
Loop sensor	Solar Electronics	9229-1	010221	2021-04	2031-04
Magnetic Field Sensor	Schwarzbeck Mess-Elektronik	FESP 5134-1	00023	2021-04	2031-04
RF Amplifier 10kHz-220MHz	Amplifier Research	250L	8645	2022-03	2023-03
RF Vector Signal Generator	Rohde & Schwarz	SMBV100A	263254	2021-05	2022-05
Oscilloscope	Agilent	54846A	MY40000254	2020-11	2022-11
Multimeter	Rohde & Schwarz	HMC8012	101577	2021-06	2022-06
Barometer	Castle	GBP 3300	072015	2022-04	2023-04
Data logger con diagnosi in campo	Testo	175-H2	20012380/305	2020-12	2022-12
Data logger con diagnosi in campo	Testo	175-H2	38203337/703	2020-12	2022-12

2. STANDARDS, TEST METHODS AND TECHNICAL PROCEDURES

2.1 Standard(s) or other specifications applied

The following standard(s) or specifications were applied:

IEC 61000-6-2:2016 / EN IEC 61000-6-2:2019
Electromagnetic compatibility (EMC) - Part 6-2: Generic standards - Immunity standard for industrial environments

IEC 61000-6-3:2020 / EN IEC 61000-6-3:2021
Electromagnetic compatibility (EMC) - Part 6-3: Generic standards - Emission standard for equipment in residential environments

2.2 Test method(s) applied

The following document(s) are referred to in the standard(s) or specifications cited at clause 2.1 in such a way that some or all of their content constitutes requirements for the standard itself. For undated document(s), only the edition cited in the standard(s) applies; dated document(s), including amendments, are used when the standard(s) requires to apply the latest edition of the referenced document:

CISPR 16-2-1 / EN 55016-2-1
Specification for radio disturbance and immunity measuring apparatus and methods - Part 2-1: Methods of measurement of disturbances and immunity - Conducted disturbance measurements

CISPR 16-2-3 / EN55016-2-3
Specification for radio disturbance and immunity measuring apparatus and methods - Part 2-3: Methods of measurement of disturbances and immunity - Radiated disturbance measurements

CISPR 32 / EN 55032
Electromagnetic compatibility of multimedia equipment – Emission requirements

CISPR 22 / EN 55022
Information technology equipment – Radio disturbance characteristics – Limits and methods of measurement

IEC 61000-3-2 / EN 61000-3-2
Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)

IEC 61000-3-3 / EN 61000-3-3
Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection

CISPR 14-1 / EN 55014-1
Electromagnetic compatibility - Requirements for household appliances, electric tools and similar apparatus - Part 1: Emission

IEC / EN 61000-4-2
Electromagnetic compatibility (EMC) -- Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test

IEC / EN 61000-4-3
Electromagnetic compatibility (EMC) -- Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test

IEC / EN 61000-4-4
Electromagnetic compatibility (EMC) -- Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test

IEC / EN 61000-4-5
Electromagnetic compatibility (EMC) -- Part 4-5: Testing and measurement techniques - Surge immunity test

IEC / EN 61000-4-6
Electromagnetic compatibility (EMC) -- Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields

IEC / EN 61000-4-8
Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test

IEC / EN 61000-4-11
Electromagnetic compatibility (EMC) -- Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests

2.3 Nemko technical procedures

WM L0177: General routines for using instruments at Nemko

WM L1002: Measurement Uncertainty - Policy and Statement

WM L0077: General procedure for conducting EMC tests

3. SUMMARY OF TEST RESULTS AND VERDICTS

3.1 Measurement of electromagnetic disturbances emitted by the equipment under test

Emission Tests		
Requirement / test	**Method Standard**	**Verdict**
Radiated emissions – enclosure port	CISPR 16-2-3 EN 55016-2-3	P
Conducted emissions – low voltage AC mains port	CISPR 16-2-1 EN 55016-2-1	P
Conducted emissions – DC power port	CISPR 16-2-1 EN 55016-2-1	P
Discontinuous disturbance – low voltage AC mains port	CISPR 14-1 EN 55014-1	P
Harmonic current emissions – low voltage AC mains port	IEC 61000-3-2 EN 61000-3-2	P
Voltage changes, voltage fluctuations and flicker – low voltage AC mains port	IEC 61000-3-3 EN 61000-3-3	P
Conducted emissions – wired network port	CISPR 32 EN 55032	N
Notes:		

3.2 Degree of immunity of the appliance to electromagnetic disturbances present in the intended use environment

Immunity Tests		
Requirement / test	**Method Standard**	**Verdict**
Enclosure ports – Electrostatic discharges	IEC / EN 61000-4-2	P
Enclosure ports – Radio-frequency electromagnetic field (AM)	IEC / EN 61000-4-3	P
Signal/control ports – Fast transients	IEC / EN 61000-4-4	N
I/O DC power ports – Fast transients	IEC / EN 61000-4-4	N
I/O AC power ports – Fast transients	IEC / EN 61000-4-4	P
Signal/control ports – Surges	IEC / EN 61000-4-5	N
I/O DC power ports – Surges	IEC / EN 61000-4-5	N
I/O AC power ports – Surges	IEC / EN 61000-4-5	P
Signal/control ports – Radio-frequency common mode	IEC / EN 61000-4-6	N
I/O DC power ports – Radio-frequency common mode	IEC / EN 61000-4-6	N
I/O AC power ports – Radio-frequency common mode	IEC / EN 61000-4-6	P
Enclosure ports – Power-frequency magnetic field	IEC / EN 61000-4-8	P
I/O AC power ports – Voltage dips and interruptions	IEC / EN 61000-4-11	P
Notes:		

4. EQUIPMENT UNDER TEST

4.1 EUT Identification

Short description of the EUT The EUT is a DIN rail power supply	
Copy of marking plate(s) (if present) --	
Sample ID .....:	4639690001 (assigned by Nemko Spa)
Model/Type reference .....:	DRB480-72-A0
Ratings .....:	Input: 3~ 400-500V / 50-60 Hz Output: 70÷85 Vdc – 6.7 A
Equipment installation .....:	Built-in
Accessories and detachable parts included ....:	None
Test performed.....:	All tests were performed on this sample
Sample ID .....:	-
Model/Type reference .....:	-
Ratings .....:	-
Equipment installation .....:	-
Accessories and detachable parts included ....:	-
Test performed.....:	-

Sample ID ..... :	-
Model/Type reference ..... :	-
Ratings ..... :	-
Equipment installation ..... :	-
Accessories and detachable parts included ... :	-
Test performed..... :	-
Software and/or firmware information ..... :	-
Product variants not tested:	

4.2 EUT Power Supply

Used [1]	N° [2]	Type	Supply Voltage	Phases N°	Supplementary Information
☒	1	AC	400 V / 50 Hz	3L+N+PE	

Notes:
[1] The crossed square indicates that the supply voltage is used in at least one test.
[2] This number will be used all over the report to identify the supply voltage(s) used for each test.

4.3 EUT Information declared by the Customer [1]

Information	Declaration
EUT highest frequency[2] .....:	fc not declared
Environment intended use.....:	Not applicable
Equipment classification[3] .....:	Class B
Equipment category[3] .....:	Not applicable

Notes:
[1] Nemko S.p.A. declines all responsibility for the information above declared by the customer that may influence the validity of the results contained in this test report.
[2] Highest frequency generated or used in the device or on which the device operates or tunes. If the clock frequency is not declared by the customer, according to the product standard(s), the worst case will be considered for each test.
[3] Equipment class and category definitions are specified in the standard used.

4.4 EUT Operation Modes

N°	Emission	Immunity	Description
1	☒	☒	EUT connected to mains and DC output connected to resistive load

Notes:

4.5 EUT Configuration Modes

Emission: the EUT was configured to measure its highest possible radiation level. The test modes selected are according to EUT instruction manual.
Immunity: the EUT was configured to have its highest possible susceptibility against tested phenomena. The test modes selected are according to EUT instruction manual.

N°	Emission	Immunity	Description
1	☒	☒	EUT connected to mains
Notes:			

4.6 EUT Input/Output Ports

Port	Name	Type [1]	Cable Max. >3m	Cable Shielded	Description
0	Enclosure	N/E	—	—	—
1	AC Mains	AC	☒	☐	Five wires cables
2	DC Output	DC	☒	☐	Two wires cable

Notes:
[1] Port type:
AC = I/O AC Power Port DC = I/O DC Power Port WN = wired network port I/O = Signal/control ports
N/E = Non-Electrical

4.7 EUT and Equipment Used During Test

Use [1]	Product Type	Manufacturer	Model	Comments
AE	Multimeter	R&S	HMC8012	Used to monitoring DC Current
AE	Multimeter	Fluke	867B	Used to monitoring DC Current

Notes:
[1] Use
EUT - Equipment Under Test SIM - Simulator (Not Subjected to Test)
AE - Auxiliary/Associated Equipment (Not Subjected to Test)

5 PERFORMANCE LEVELS

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test (criterion), relative to a performance level defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product.

Performance level definition	
☒	based on the used product standard
☐	based on the declaration of the manufacturer, requestor or purchaser

The following performance criteria are defined by the product standard:

Criterion	Description from standard
A	The EUT shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the EUT is used as intended. If the performance level is not specified by the manufacturer, this may be derived from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.
B	The EUT shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. However, during the test degradation of performance is allowed but no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.
C	Temporary loss of function is allowed during the test, provided the function is self-recoverable or can be restored by the operation of the controls.

For each criterion, the following representative parameters and performance level were checked during immunity tests:

Criterion	Immunity Test	Representative parameter	Performance level
A	All applicable	DC Current	No Change allowed
B	All applicable	DC Current	Allowed a small change of current (±10%)
C	All applicable	DC Current	A current interruption is allowed but EUT must restart itself

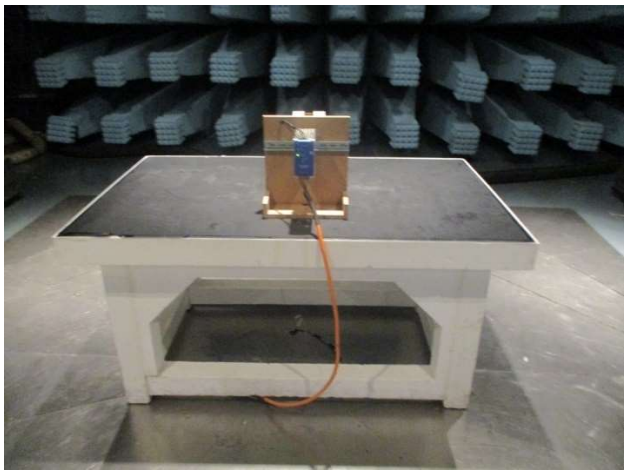
6 TEST RESULTS

6.1 Radiated emissions

6.1.1 Test result

Verdict:	☒ P ☐ F ☐ N[1] ☐ NP
Frequency range:	30 MHz – 6 000 MHz
Test site:	Semi anechoic chamber
Measurement distance:	10 m and 3 m
Notes: [1] If marked, the test is not applicable for the EUT	

6.1.2 Photo documentation of the test set-up



6.1.3 Test method

Method standard is reported at par. 3.1. Measurements were made on a semi anechoic chamber. Preliminary (peak) measurements were performed at an antenna to EUT separation distance of 10 meters with the receiving antenna located at a fixed height (from 1 to 4 meter) in both horizontal and vertical polarities. Final measurements (quasi-peak) were then performed by rotating the EUT 360° and adjusting the receiving antenna height from 1 to 4 meters. All frequencies were investigated in both horizontal and vertical antenna polarity, where applicable.

6.1.4 Limits for enclosure

Radiated emissions – enclosure port			
Frequency (MHz)	**Quasi-Peak limit (dBµV/m)**	**Average limit (dBµV/m)**	**Peak limit (dBµV/m)**
30 to 230	30	-	-
230 to 1000	37	-	-
1000 to 3000	-	50	70
3000 to 6000	-	54	74

Notes:
[1] The limit decreases linearly with the logarithm of the frequency
[2] The limit decreases linearly with the frequency

6.1.5 Test equipment used[1]

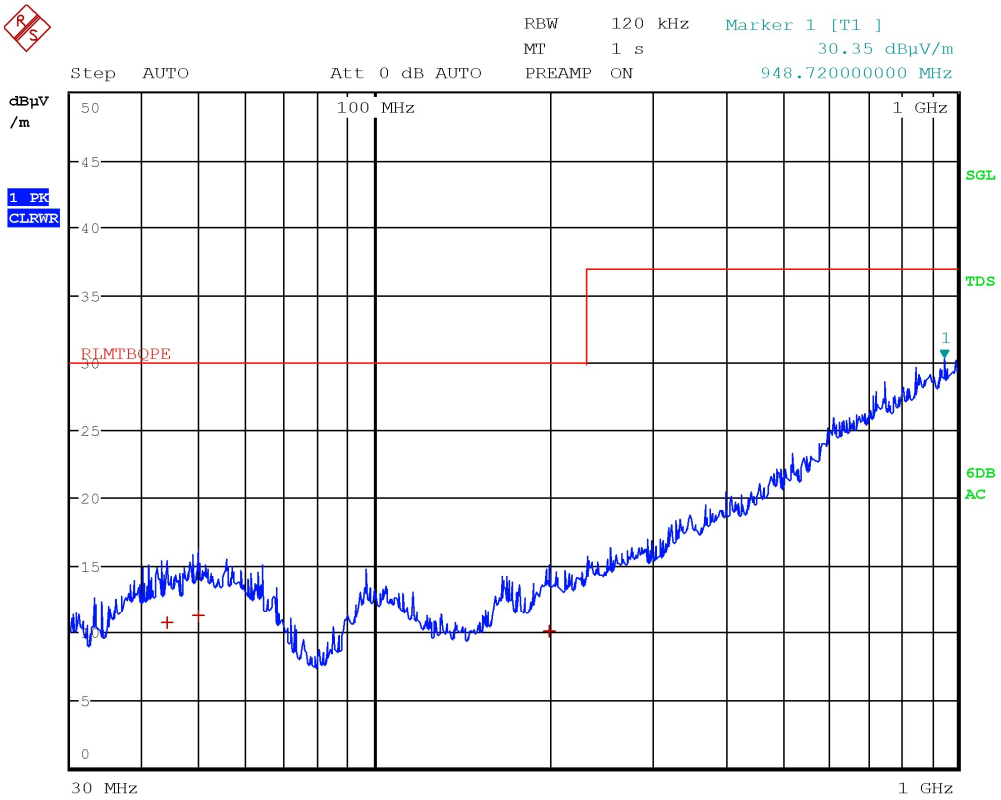
Used [2]	Description	Manufacturer	Model	Identifier
☒	SAC	Nemko Spa	10m SAC	530
☒	EMI receiver	Rohde & Schwarz	ESW44	101620
☐	EMI receiver	R&S	ESU8	100202
☐	Common mode absorption device	Schwarzbeck	CMAD1614	00041
☒	Antenna	Schwarzbeck	VULB9162	VULB9162-025
☐	Antenna	Schwarzbeck	VULB9168	VULB9168-242
☒	Antenna	Schwarzbeck	STLP9148	STLP9148-123
☐	Antenna	Schwarzbeck	STLP9148	STLP9148-152
☐	Preamplifier	Schwarzbeck	BBV9718	BBV9718-137
☒	Preamplifier	Schwarzbeck	BBV9718C	00121
☒	Controller for turntable and antenna mast	Maturo	FCU3.0	10041
☒	Tilt antenna mast	Maturo	TAM4.0-E	10042
☒	Turntable 4.5 t	Maturo	TT4.0-5T	2.527

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.1.6 Test protocol

Antenna Polarization	Supply Voltage[1]	Test Mode		Remarks	Verdict
		Operation[2]	Configuration[3]		
Horizontal	1	1	1	30 MHz – 1000 MHz	P

Notes:
[1] See clause 4.2 EUT Power Supply
[2] See clause 4.4 EUT Operation Modes
[3] See clause 4.5 EUT Configuration Modes



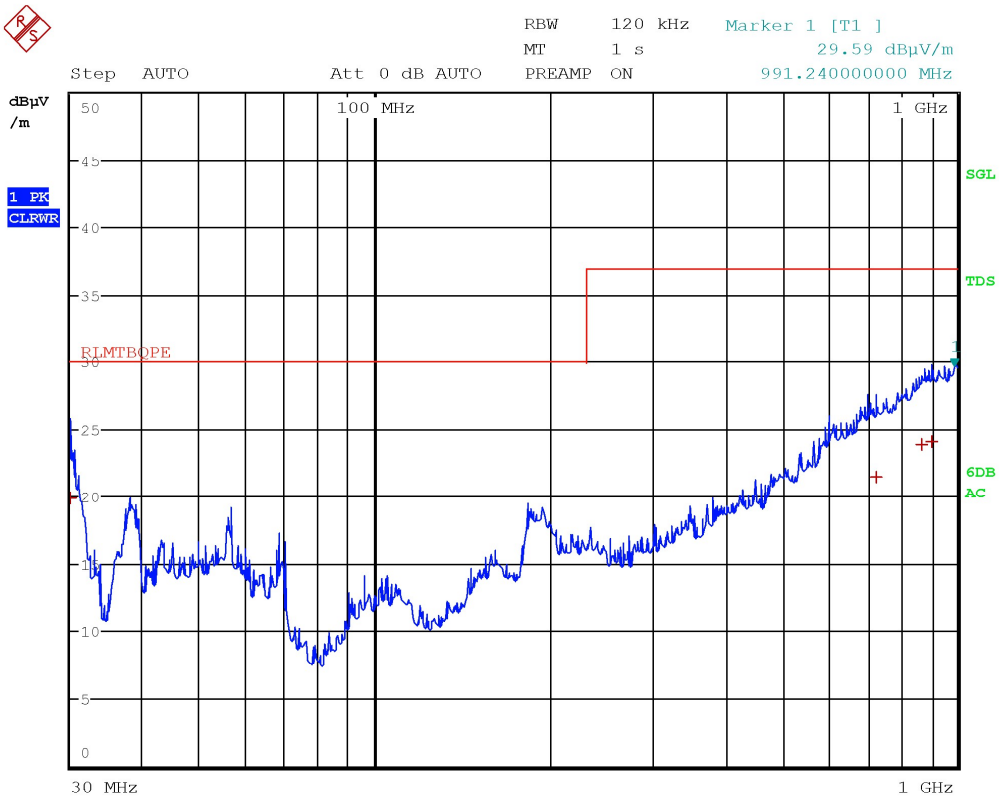
EDIT PEAK LIST (Final Measurement Results)

Trace1:	RLMTBQPE
Trace2:	---
Trace3:	---

TRACE	FREQUENCY	LEVEL dBµV/m	DELTA LIMIT dB
1 Quasi Peak	44.04 MHz	10.71	-19.28
1 Quasi Peak	49.72 MHz	11.27	-18.72
1 Quasi Peak	199.48 MHz	10.12	-19.87

Antenna Polarization	Supply Voltage[1]	Test Mode		Remarks	Verdict
		Operation[2]	Configuration[3]		
Vertical	1	1	1	30 MHz – 1000 MHz	P

Notes:
[1] See clause 4.2 EUT Power Supply
[2] See clause 4.4 EUT Operation Modes
[3] See clause 4.5 EUT Configuration Modes



EDIT PEAK LIST (Final Measurement Results)

Trace1: RLMTBQPE
Trace2: ---
Trace3: ---

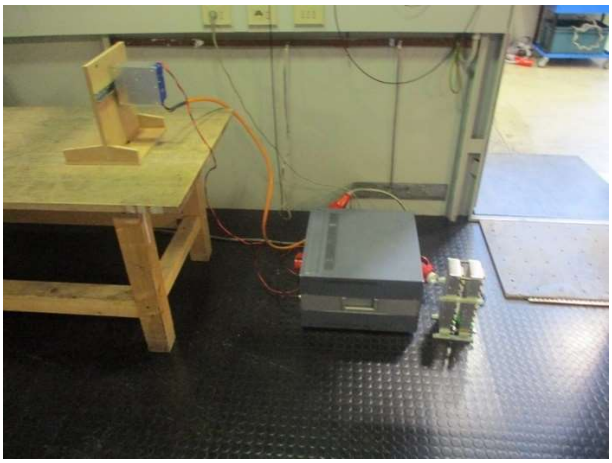
TRACE	FREQUENCY	LEVEL dBµV/m	DELTA LIMIT dB
1 Quasi Peak	30.04 MHz	19.85	-10.14
1 Quasi Peak	726.32 MHz	21.49	-15.50
1 Quasi Peak	867.84 MHz	23.86	-13.13
1 Quasi Peak	902.44 MHz	24.07	-12.92

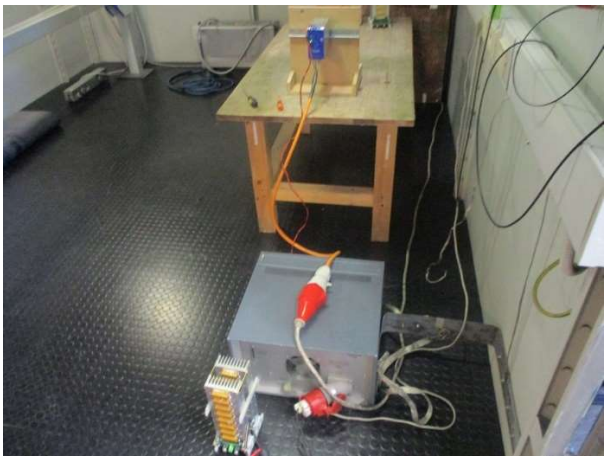
6.2 Conducted emissions

6.2.1 Test result

Verdict for low voltage AC mains port:	☒ P	☐ F	☐ N[1]	☐ NP
Verdict for DC power port:	☒ P	☐ F	☒ N[1]	☐ NP
Verdict for wired network port:	☐ P	☐ F	☒ N[1]	☐ NP
Frequency range:	0.15 MHz – 30 MHz			
Kind of test site:	Shielded room			
Notes: [1] If marked, the test is not applicable for the EUT				

6.2.2 Photo documentation of the test set-up





6.2.3 Test method

Method standard is reported at par. 3.1. Measurements were made on a ground plane that extends one meter minimum beyond all sides of the system under test. All power was connected to the system through Line Impedance Stabilization Networks (LISN). Conducted voltage measurements on mains lines were made at the output of the LISN. All tested telecommunications lines were connected to an Impedance Stabilization Network (ISN) and conducted voltage measurements on telecommunications lines were made at the output of the ISN. Where an ISN was not appropriate or available measurements were made using a Capacitive Voltage Probe and Current probe.

6.2.4 Limits

Conducted emissions – low voltage AC mains port		
Frequency (MHz)	**Quasi-Peak limit (dBµV)**	**Average limit (dBµV)**
0.15 to 0.50	66 to 56 [1]	56 to 46 [1]
0.50 to 5	56	46
5 to 30	60	50
Notes: [1] The limits decrease linearly with the logarithm of the frequency		

Conducted emissions – DC power port		
Frequency (MHz)	**Quasi-Peak limit (dBµV)**	**Average limit (dBµV)**
0.15 to 0.50	79	66
0.50 to 30	73	60
Notes:		

Conducted emissions – wired network port[1]				
Frequency (MHz)	**Quasi-Peak limit**		**Average limit**	
	dB(µV)	**dB(µA)**	**dB(µV)**	**dB(µA)**
0.15 to 0.50	84 to 74 [2]	40 to 30 [2]	74 to 64 [2]	30 to 20 [2]
0.50 to 30	74	30	64	20
Notes: [1] Applicable to wired network, optical fiber (with metallic shield or tension member) and antenna ports [2] The limits decrease linearly with the logarithm of the frequency				

6.2.5 Test equipment used[1]

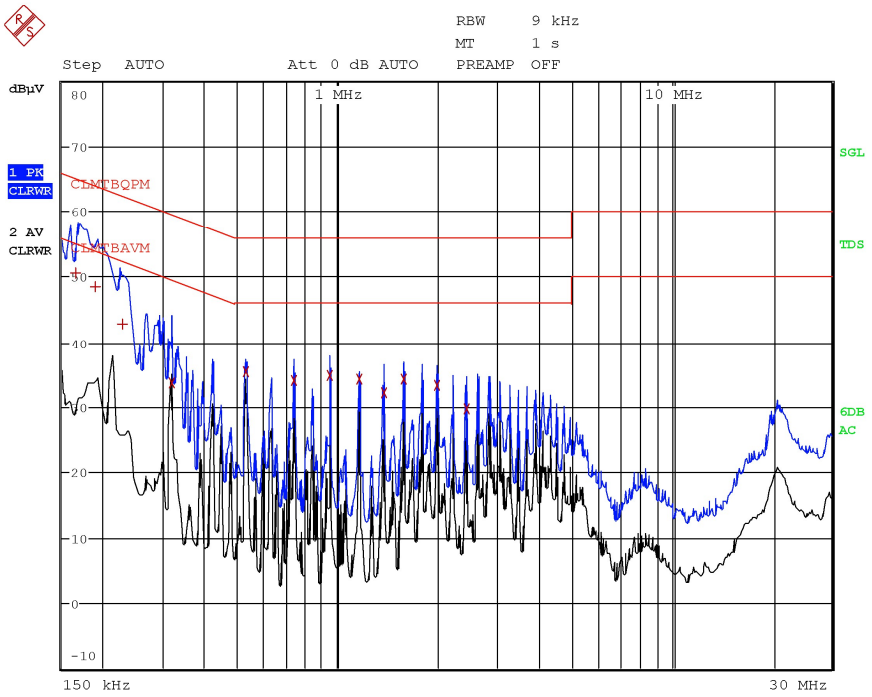
Used [2]	Description	Manufacturer	Model	Identifier
☒	EMI receiver	R&S	ESU8	100202
☐	EMI receiver	Rohde & Schwarz	ESW44	101620
☒	Attenuator	Aeroflex / Weinschel	2	CC8577
☐	LISN 9 kHz ÷ 30 MHz	R&S	ESH2-Z5	872 460/041
☒	LISN 9 kHz ÷ 30 MHz	R&S	ESH2-Z5	881 362/006
☐	LISN 9 kHz ÷ 30 MHz	R&S	ESH3-Z5	840 731/004
☐	Current clamp probe	R&S	ESH2-Z1	891 923/18
☐	Voltage Probe	Rorhbacher	VP-1	2.455
☐	ISN	Schwarzbeck	NTFM8131	8131-153
☐	ISN	Teseq	ISN T8	47263
☒	Shielded room	Siemens	Conducted emission test room	1862

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.2.6 Test protocol

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	L1	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes



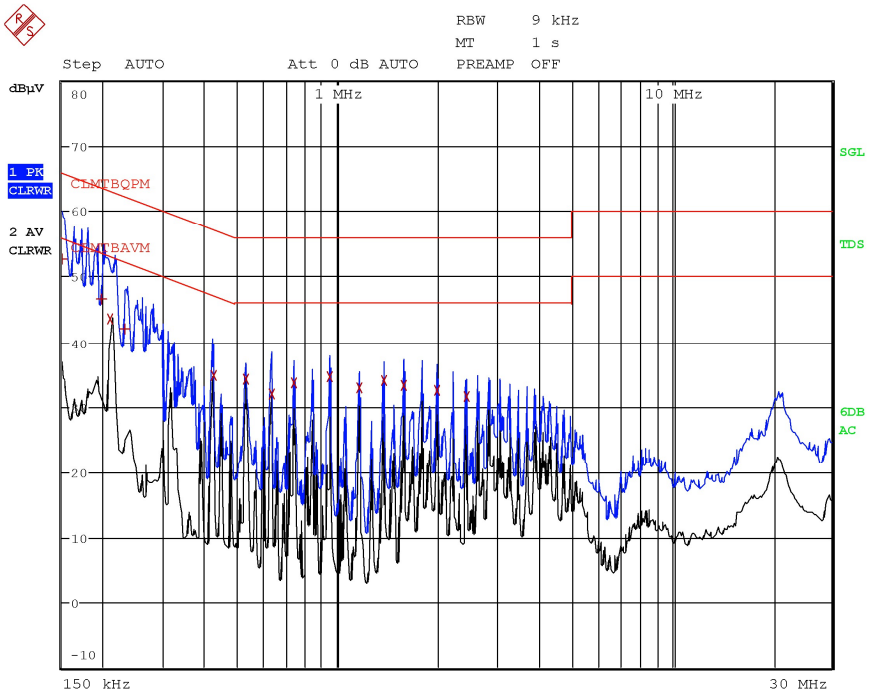
EDIT PEAK LIST (Final Measurement Results)

Trace1: CLMTBQPM
Trace2: CLMTBAVM
Trace3: ---

TRACE		FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
1	Quasi Peak	166 kHz	50.57	-14.58
1	Quasi Peak	190 kHz	48.49	-15.54
1	Quasi Peak	230 kHz	42.75	-19.69
2	Average	318 kHz	33.76	-15.99
2	Average	526 kHz	35.38	-10.61
2	Average	734 kHz	34.08	-11.91
2	Average	946 kHz	34.95	-11.04
2	Average	1.158 MHz	34.42	-11.57
2	Average	1.37 MHz	32.35	-13.64
2	Average	1.578 MHz	34.27	-11.73
2	Average	1.998 MHz	33.44	-12.55
2	Average	2.422 MHz	29.84	-16.15

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	L2	1	1	1		P

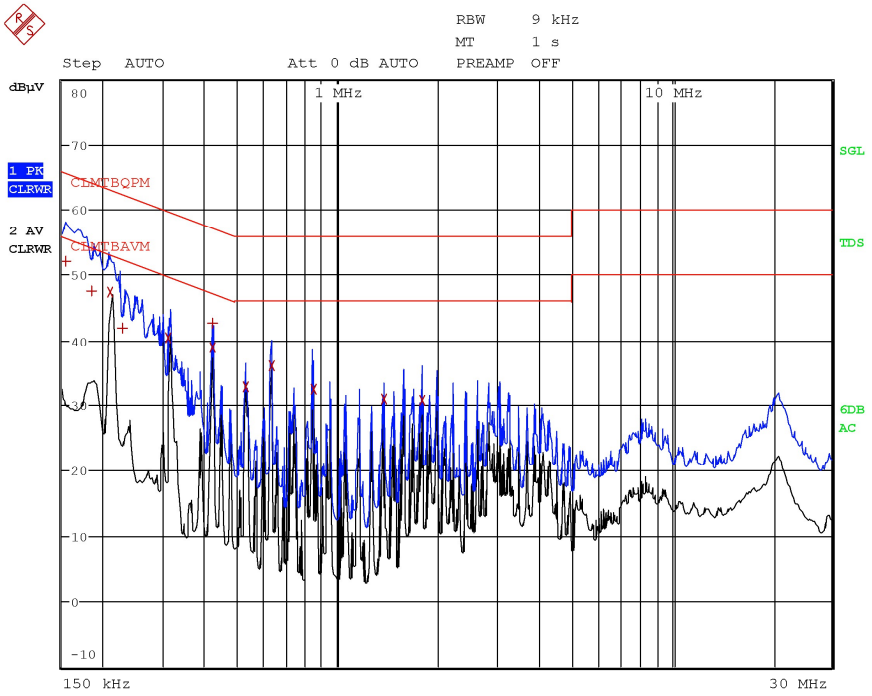
Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes



EDIT PEAK LIST (Final Measurement Results)			
Trace1:	CLMTBQPM		
Trace2:	CLMTBAVM		
Trace3:	---		
TRACE	FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
1 Quasi Peak	150 kHz	52.76	-13.23
1 Quasi Peak	198 kHz	46.57	-17.12
2 Average	210 kHz	43.66	-9.54
1 Quasi Peak	234 kHz	42.02	-20.28
2 Average	422 kHz	34.90	-12.50
2 Average	526 kHz	34.25	-11.74
2 Average	630 kHz	32.08	-13.91
2 Average	734 kHz	33.83	-12.16
2 Average	946 kHz	34.68	-11.31
2 Average	1.158 MHz	32.93	-13.06
2 Average	1.366 MHz	34.23	-11.76
2 Average	1.578 MHz	33.35	-12.64
2 Average	1.998 MHz	32.63	-13.36
2 Average	2.418 MHz	31.64	-14.35

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	L3	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes



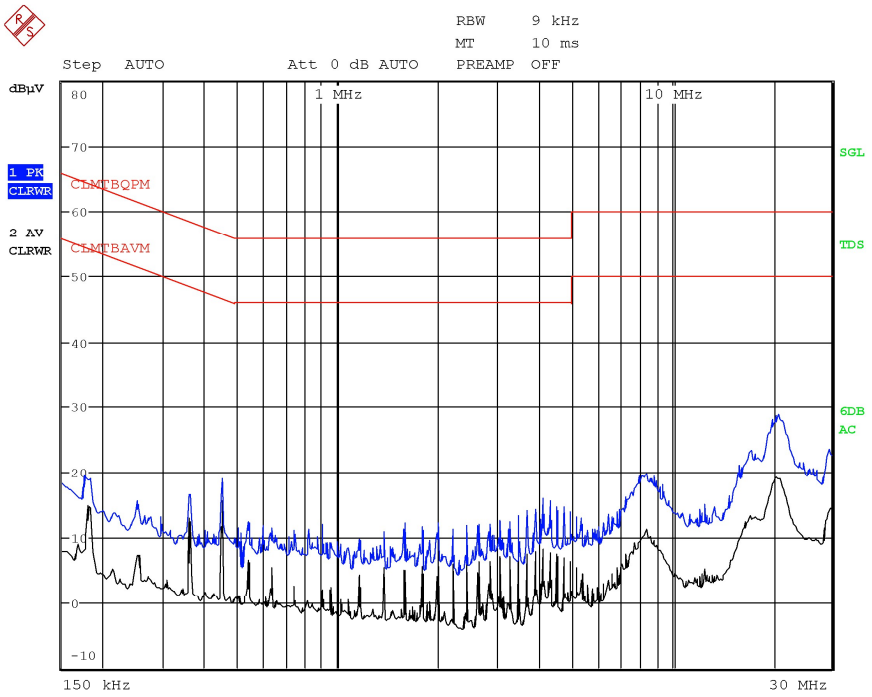
EDIT PEAK LIST (Final Measurement Results)

Trace1: CLMTBQPM
Trace2: CLMTBAVM
Trace3: ---

TRACE	FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
1 Quasi Peak	154 kHz	52.13	-13.64
1 Quasi Peak	186 kHz	47.53	-16.67
2 Average	210 kHz	47.38	-5.82
1 Quasi Peak	230 kHz	41.93	-20.51
2 Average	314 kHz	40.30	-9.55
1 Quasi Peak	418 kHz	42.67	-14.80
2 Average	418 kHz	38.85	-8.63
2 Average	526 kHz	32.79	-13.20
2 Average	630 kHz	35.94	-10.05
2 Average	842 kHz	32.40	-13.59
2 Average	1.366 MHz	30.90	-15.09
2 Average	1.786 MHz	30.80	-15.19

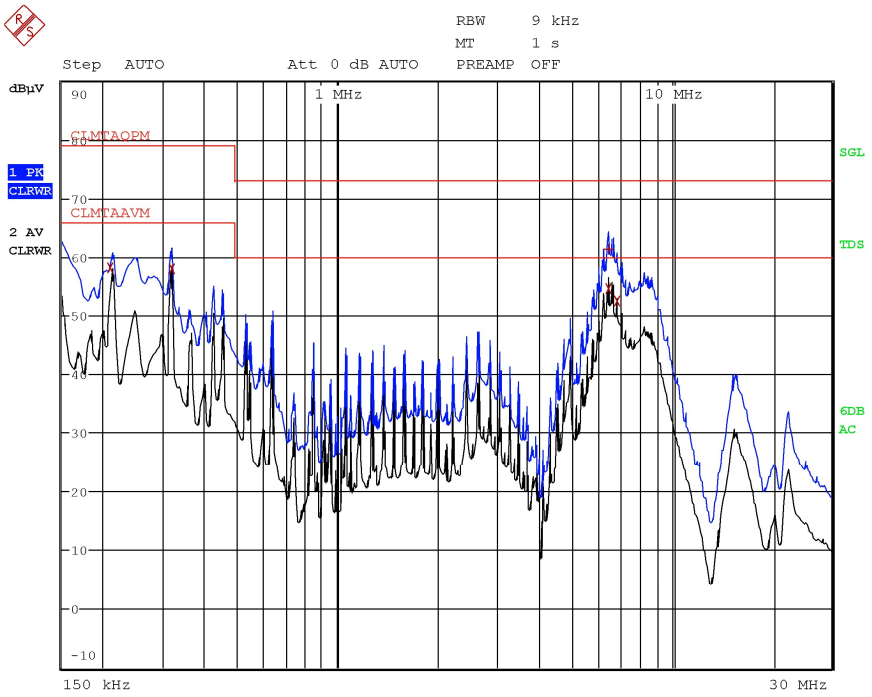
Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	N	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes



EUT[1]	Line		Operation[3]	Configuration[4]		
1	+ 72 VDC	1	1	1	Output	P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes



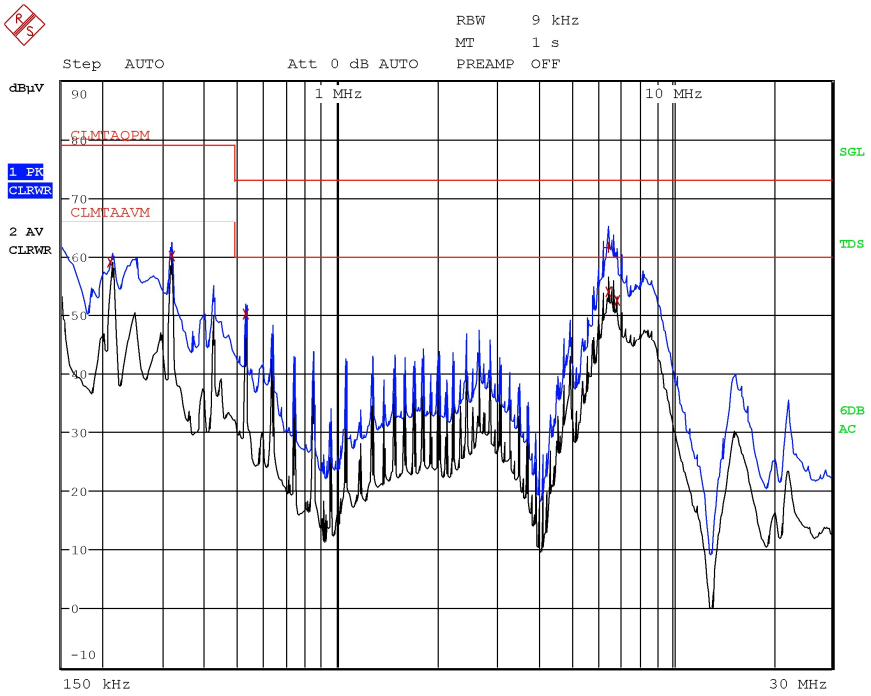
EDIT PEAK LIST (Final Measurement Results)

Trace1: CLMTAQPM
Trace2: CLMTAAVM
Trace3: ---

TRACE	FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
2 Average	210 kHz	58.08	-7.91
2 Average	318 kHz	58.03	-7.96
1 Quasi Peak	6.434 MHz	61.32	-11.67
2 Average	6.438 MHz	54.50	-5.49
2 Average	6.85 MHz	52.57	-7.42

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	-72 VDC	1	1	1	Output	P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes



EDIT PEAK LIST (Final Measurement Results)

Trace1: CLMTAQPM
Trace2: CLMTAAVM
Trace3: ---

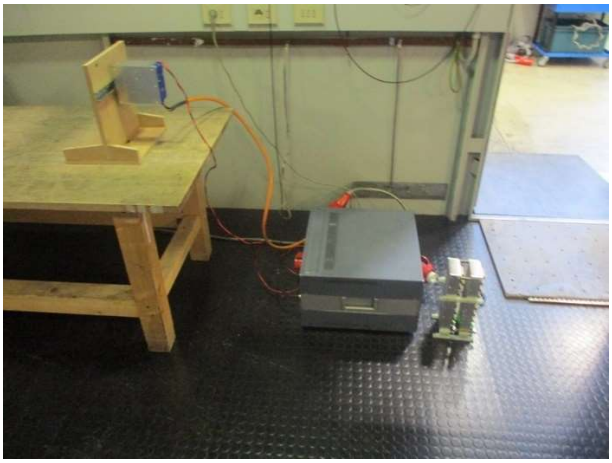
TRACE	FREQUENCY	LEVEL dBµV	DELTA LIMIT dB
2 Average	210 kHz	59.11	-6.88
2 Average	318 kHz	60.06	-5.93
2 Average	526 kHz	50.29	-9.70
1 Quasi Peak	6.438 MHz	61.47	-11.52
2 Average	6.446 MHz	54.07	-5.92
2 Average	6.854 MHz	52.53	-7.46

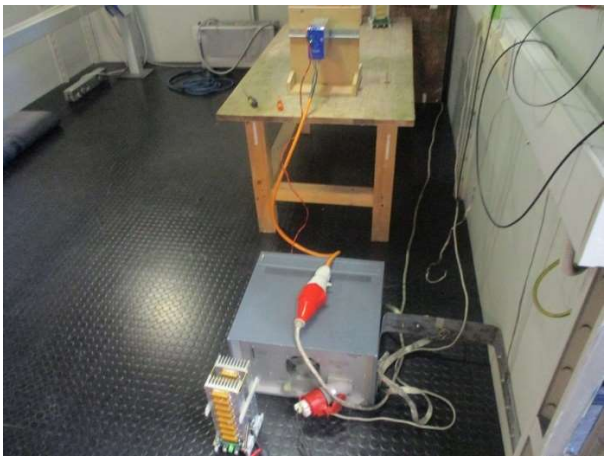
6.3 Discontinuous disturbance

6.3.1 Test result

Verdict:	☒ P ☐ F ☐ N[1] ☐ NP
Frequency range:	0.15 MHz – 30 MHz
Kind of test site:	Shielded room
Notes: [1] If marked, the test is not applicable for the EUT	

6.3.2 Photo documentation of the test set-up





6.3.3 Test method

Method standard is reported at par. 3.1. Measurement of a disturbance, the amplitude of which exceeds the quasi-peak limit of continuous disturbance, the duration of which is not longer than 200 ms which is separated from a subsequent disturbance by at least 200 ms.

6.3.4 Limits

The limits for discontinuous disturbance depend mainly on the character of the disturbance and on the click rate N. For the first measurement with the limit L and a time of measurement equal to T or 120 minutes, the click rate is obtained with N = (Number of clicks or switching operation / Time of measurement).

Appliance which has a click rate N less than 5 clicks per minute, and which has instantaneous switching (90% clicks shorter than 10 ms and none longer than 20ms) shall be deemed to comply with the limits, regardless of the click's amplitude. Otherwise a second measurement is needed.

For the second measurement, the click limit Lq is obtained by increasing the relevant limit L with 44 dB for N < 0.2, or 20log(30 / N) for 0.2 ≤ N < 30. With the limit Lq during the same time T or 120 minutes, the number of authorized clicks is equal to N2 ≤N1/4

6.3.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☒	EMI receiver	R&S	ESU8	100202
☐	EMI receiver	Rohde & Schwarz	ESW44	101620
☒	Attenuator	Aeroflex / Weinschel	2	CC8577
☐	LISN 9 kHz ÷ 30 MHz	R&S	ESH2-Z5	872 460/041
☒	LISN 9 kHz ÷ 30 MHz	R&S	ESH2-Z5	881 362/006
☐	LISN 9 kHz ÷ 30 MHz	R&S	ESH3-Z5	840 731/004
☒	Shielded room	Siemens	Conducted emission test room	1862

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.3.6 Test protocol

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	L1, L2, L3	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes

FIRST RUN							
Frequency (MHz)	Limit (dBµV)	Number of clicks			Switching operations	Time (min)	Click rate N
		< 10 ms	10ms to 20ms	> 20 ms			
0.15	66	0	0	0	-	120	0
0.5	56	0	0	0	-	120	0
1.4	56	0	0	0	-	120	0
30	60	0	0	0	-	120	0

Second run not necessary

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	N	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes

FIRST RUN							
Frequency (MHz)	Limit (dBµV)	Number of clicks			Switching operations	Time (min)	Click rate N
		< 10 ms	10ms to 20ms	> 20 ms			
0.15	66	0	0	0	-	120	0
0.5	56	0	0	0	-	120	0
1.4	56	0	0	0	-	120	0
30	60	0	0	0	-	120	0

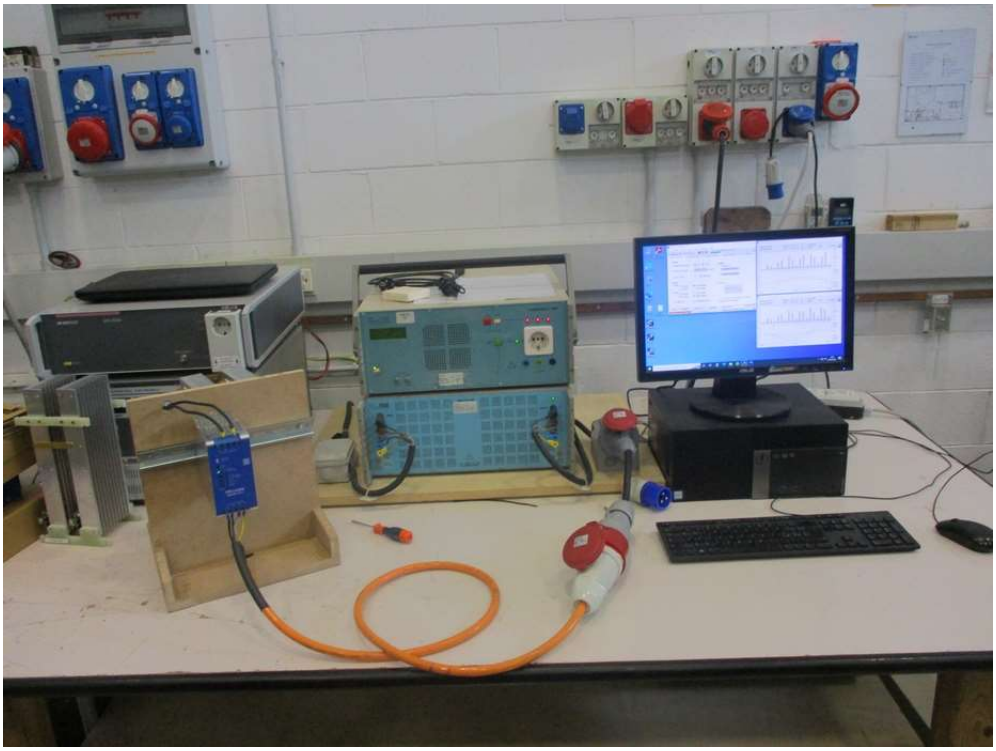
Second run not necessary

6.4 Harmonics of current

6.4.1 Test result

Verdict:	☒ P ☐ F ☐ N[1] ☐ NP
Frequency range:	0 kHz – 2 kHz
Class:	☒ A
Notes: [1] If marked, the test is not applicable for the EUT, active power less than 75 W	

6.4.2 Photo documentation of the test set-up



6.4.3 Test method

Method standard is reported at par. 3.1. This test consists on the measurement of harmonics components of the input current which may be produced by equipment having an input current up to and including 16 A per phase, and intended to be connected to public low-voltage distribution systems. The equipment is tested under specified conditions of operation.

6.4.4 Limits

Harmonic type	Harmonic order	Maximum permissible harmonic current (A)	
		Class A Equipment	Class B Equipment
Odd	3	2.30	3.45
	5	1.14	1.71
	7	0.77	1.155
	9	0.40	0.60
	11	0.33	0.495
	13	0.21	0.315
	15 ≤ n ≤ 40	0.15 x 15/n	0.225 x 15/n
Even	2	1.08	1.62
	4	0.43	0.645
	6	0.30	0.45
	8 ≤ n ≤ 40	0.23 x 8/n	0.345 x 8/n
Notes:			

6.4.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☐	Harmonics and Flicker analyser	Emc Partner	Harmonics 1000	016+103489
☒	Harmonics and Flicker analyser	EM Test	DPA500N	P1735202736
☒	Power source	Elettrotest	TPS/M/6000	358 04/18

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.4.6 Test protocol

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	L	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes

3ph - System [Phase L1]

Urms =	231.3V	Freq =	50.000	Range:	10 A
Irms =	0.742A	Ipk =	1.104A	cf =	1.487
P =	163.2W	S =	171.7VA	pf =	0.951
THDi =	31.4 %	THDu =	0.10 %	Class A	

Test - Time : 5min (100 %)

Test completed, Result: PASSED

Order	Freq. [Hz]	Iavg [A]	Irms [A]	Imax [A]	Limit [A]	Status
1	50	0.7089	0.7092	0.7123		
2	100	0.0032	0.0006	0.0317	1.0800	
3	150	0.0040	0.0037	0.0079	2.3000	
4	200	0.0023	0.0006	0.0238	0.4300	
5	250	0.1659	0.1666	0.1666	1.1400	
6	300	0.0045	0.0006	0.0446	0.3000	
7	350	0.0885	0.0885	0.0909	0.7700	
8	400	0.0013	0.0006	0.0128	0.2300	
9	450	0.0001	0.0043	0.0055	0.4000	
10	500	0.0025	0.0006	0.0256	0.1840	
11	550	0.0600	0.0586	0.0647	0.3300	
12	600	0.0037	0.0012	0.0372	0.1533	
13	650	0.0571	0.0598	0.0604	0.2100	
14	700	0.0012	0.0006	0.0116	0.1314	
15	750	0.0000	0.0024	0.0049	0.1500	
16	800	0.0025	0.0006	0.0256	0.1150	
17	850	0.0450	0.0470	0.0476	0.1324	
18	900	0.0031	0.0006	0.0305	0.1022	
19	950	0.0294	0.0299	0.0317	0.1184	
20	1000	0.0010	0.0006	0.0110	0.0920	
21	1050	0.0004	0.0043	0.0049	0.1071	
22	1100	0.0023	0.0006	0.0226	0.0836	
23	1150	0.0232	0.0238	0.0250	0.0978	
24	1200	0.0025	0.0012	0.0256	0.0767	
25	1250	0.0321	0.0348	0.0348	0.0900	
26	1300	0.0009	0.0006	0.0098	0.0708	
27	1350	0.0007	0.0018	0.0085	0.0833	
28	1400	0.0019	0.0006	0.0195	0.0657	
29	1450	0.0248	0.0269	0.0281	0.0776	
30	1500	0.0020	0.0006	0.0201	0.0613	
31	1550	0.0174	0.0183	0.0195	0.0726	
32	1600	0.0007	0.0012	0.0079	0.0575	
33	1650	0.0020	0.0037	0.0110	0.0682	
34	1700	0.0016	0.0006	0.0165	0.0541	
35	1750	0.0138	0.0140	0.0159	0.0643	
36	1800	0.0014	0.0006	0.0146	0.0511	
37	1850	0.0227	0.0256	0.0262	0.0608	
38	1900	0.0006	0.0006	0.0067	0.0484	
39	1950	0.0010	0.0018	0.0110	0.0577	
40	2000	0.0011	0.0006	0.0122	0.0460	

Important:
- 35% of time voltage "out of Spec"

3ph - System [Phase L2]

Urms =	231.5V	Freq =	49.984	Range:	10 A
Irms =	0.732A	Ipk =	1.152A	cf =	1.573
P =	161.0W	S =	169.5VA	pf =	0.950
THDi =	31.8 %	THDu =	0.20 %	Class A	

Order	Freq. [Hz]	Iavg [A]	Irms [A]	Imax [A]	Limit [A]	Status
1	50	0.7029	0.6995	0.7208		
2	100	0.0040	0.0006	0.0391	1.0800	
3	150	0.0087	0.0067	0.0189	2.3000	
4	200	0.0036	0.0012	0.0360	0.4300	
5	250	0.1649	0.1636	0.1727	1.1400	
6	300	0.0010	0.0012	0.0098	0.3000	
7	350	0.0897	0.0903	0.0934	0.7700	
8	400	0.0026	0.0012	0.0256	0.2300	
9	450	0.0031	0.0037	0.0092	0.4000	
10	500	0.0011	0.0006	0.0110	0.1840	
11	550	0.0618	0.0647	0.0647	0.3300	
12	600	0.0025	0.0012	0.0244	0.1533	
13	650	0.0551	0.0549	0.0574	0.2100	
14	700	0.0023	0.0006	0.0226	0.1314	
15	750	0.0067	0.0049	0.0177	0.1500	
16	800	0.0033	0.0012	0.0336	0.1150	
17	850	0.0471	0.0464	0.0482	0.1324	
18	900	0.0017	0.0012	0.0165	0.1022	
19	950	0.0319	0.0323	0.0354	0.1184	
20	1000	0.0016	0.0012	0.0165	0.0920	
21	1050	0.0032	0.0037	0.0134	0.1071	
22	1100	0.0016	0.0006	0.0159	0.0836	
23	1150	0.0254	0.0287	0.0287	0.0978	
24	1200	0.0010	0.0043	0.0110	0.0767	
25	1250	0.0291	0.0299	0.0323	0.0900	
26	1300	0.0022	0.0012	0.0214	0.0708	
27	1350	0.0056	0.0049	0.0171	0.0833	
28	1400	0.0021	0.0012	0.0208	0.0657	
29	1450	0.0272	0.0275	0.0287	0.0776	
30	1500	0.0015	0.0012	0.0153	0.0613	
31	1550	0.0188	0.0195	0.0208	0.0726	
32	1600	0.0008	0.0049	0.0073	0.0575	
33	1650	0.0031	0.0043	0.0195	0.0682	
34	1700	0.0019	0.0012	0.0140	0.0541	
35	1750	0.0162	0.0183	0.0183	0.0643	
36	1800	0.0005	0.0012	0.0061	0.0511	
37	1850	0.0195	0.0208	0.0238	0.0608	
38	1900	0.0018	0.0012	0.0146	0.0484	
39	1950	0.0038	0.0055	0.0128	0.0577	
40	2000	0.0013	0.0012	0.0098	0.0460	

3ph - System [Phase L3]

Urms =	231.1V	Freq =	49.984	Range:	10 A
Irms =	0.732A	Ipk =	1.133A	cf =	1.547
P =	160.3W	S =	169.3VA	pf =	0.947
THDi =	32.3 %	THDu =	0.20 %	Class A	

Order	Freq. [Hz]	Iavg [A]	Irms [A]	Imax [A]	Limit [A]	Status
1	50	0.6952	0.6958	0.7007		
2	100	0.0026	0.0006	0.0262	1.0800	
3	150	0.0024	0.0043	0.0232	2.3000	
4	200	0.0024	0.0006	0.0238	0.4300	
5	250	0.1664	0.1666	0.1782	1.1400	
6	300	0.0051	0.0012	0.0513	0.3000	
7	350	0.0871	0.0879	0.0903	0.7700	
8	400	0.0027	0.0012	0.0275	0.2300	
9	450	0.0013	0.0049	0.0085	0.4000	
10	500	0.0024	0.0006	0.0238	0.1840	
11	550	0.0667	0.0665	0.0696	0.3300	
12	600	0.0062	0.0012	0.0610	0.1533	
13	650	0.0493	0.0519	0.0519	0.2100	
14	700	0.0011	0.0006	0.0116	0.1314	
15	750	0.0030	0.0049	0.0183	0.1500	

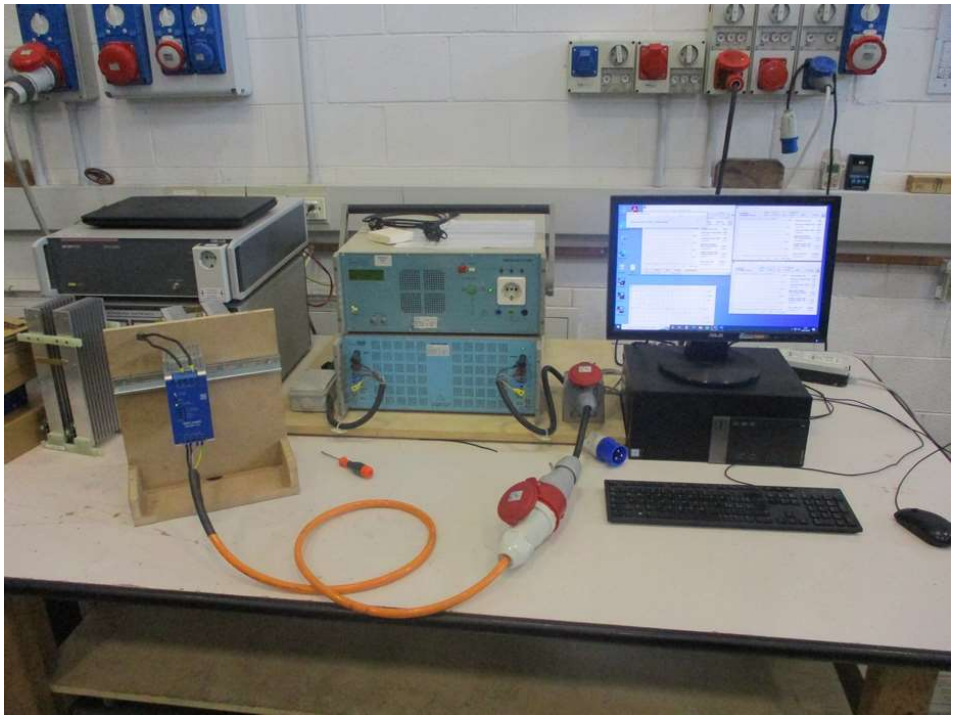
16	800	0.0021	0.0012	0.0214	0.1150
17	850	0.0471	0.0494	0.0500	0.1324
18	900	0.0039	0.0006	0.0385	0.1022
19	950	0.0300	0.0311	0.0330	0.1184
20	1000	0.0018	0.0006	0.0189	0.0920
21	1050	0.0015	0.0037	0.0140	0.1071
22	1100	0.0028	0.0006	0.0275	0.0836
23	1150	0.0295	0.0311	0.0323	0.0978
24	1200	0.0035	0.0037	0.0354	0.0767
25	1250	0.0249	0.0269	0.0275	0.0900
26	1300	0.0013	0.0006	0.0122	0.0708
27	1350	0.0024	0.0049	0.0092	0.0833
28	1400	0.0010	0.0012	0.0116	0.0657
29	1450	0.0285	0.0305	0.0311	0.0776
30	1500	0.0029	0.0012	0.0299	0.0613
31	1550	0.0182	0.0183	0.0201	0.0726
32	1600	0.0009	0.0049	0.0092	0.0575
33	1650	0.0021	0.0031	0.0140	0.0682
34	1700	0.0024	0.0012	0.0195	0.0541
35	1750	0.0199	0.0208	0.0226	0.0643
36	1800	0.0019	0.0012	0.0146	0.0511
37	1850	0.0179	0.0189	0.0208	0.0608
38	1900	0.0011	0.0012	0.0085	0.0484
39	1950	0.0029	0.0055	0.0079	0.0577
40	2000	0.0003	0.0012	0.0061	0.0460

6.5 Voltage changes, voltage fluctuations and flicker

6.5.1 Test result

Verdict:	☐ P	☐ F	☐ N[1]	☒ NP
Notes: [1] If marked, the test is not applicable for the EUT				

6.5.2 Photo documentation of the test set-up



6.5.3 Test method

Method standard is reported at par. 3.1. This test consists in the measurement of voltage changes, voltage fluctuations and flicker which may be produced by equipment having an input current ≤ 16 A per phase, and intended to be connected to public low-voltage distribution systems. The equipment is tested under specified conditions of operation.

6.5.4 Limits

The value of Pst shall be not greater than 1.0.
The value of Plt shall be not greater than 0.65.
The value of d(t) during a voltage change shall not exceed 3.3 % for more than 500 ms.
The relative steady-state voltage change, dc shall not exceed 3.3 %.
The maximum relative voltage change dmax shall not exceed:

a) 4 % without additional conditions
b) 6 % for equipment which is switched manually, or switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption
c) 7 % for equipment which is attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as mowers, portable tools such as electric drills), or switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

6.5.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☐	Harmonics and Flicker analyser	Emc Partner	Harmonics 1000	016+103489
☒	Harmonics and Flicker analyser	EM Test	DPA500N	P1735202736
☒	Power source	Elettrotest	TPS/M/6000	358 04/18

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.5.6 Test protocol

Test Port		Supply Voltage[2]	Test Mode		Remarks	Verdict
EUT[1]	Line		Operation[3]	Configuration[4]		
1	L	1	1	1		P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See clause 4.2 EUT Power Supply
[3] See clause 4.4 EUT Operation Modes
[4] See clause 4.5 EUT Configuration Modes

3ph - System [Phase L1]

Urms = 231.1V Freq = 49.984 Range: 2 A
Irms = 0.734A Ipk = 1.098A cf = 1.495
P = 161.4W S = 169.7VA pf = 0.951

Test - Time : 1 x 10min = 10min (100 %)

LIN (Line Impedance Network) : L: 0.24ohm +j0.15ohm N: 0.16ohm +j0.10ohm

Limits : Plt : 0.65 Pst : 1.00
dmax : 4.00 % dc : 3.00 %
dtLim: 3.00 % dt>Lim: 200ms

Test completed, Result: PASSED

	dmax [%]
1	0.000

3ph - System [Phase L2]

Urms = 231.5V Freq = 49.984 Range: 2 A
Irms = 0.730A Ipk = 1.102A cf = 1.508
P = 160.8W S = 169.1VA pf = 0.951

	dmax [%]
1	0.000

3ph - System [Phase L3]

Urms = 231.1V Freq = 49.984 Range: 2 A

Irms =	0.729A	Ipk =	1.138A	cf =	1.560		
P =	160.0W	S =	168.6VA	pf =	0.949		

	dmax [%]
1	0.000

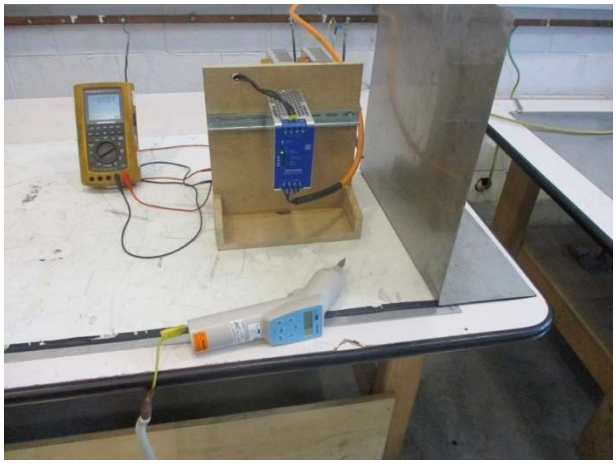
6.6 Electrostatic discharges

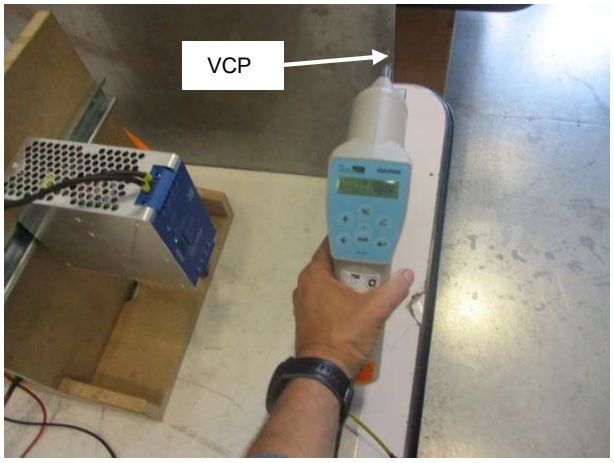
6.6.1 Test result

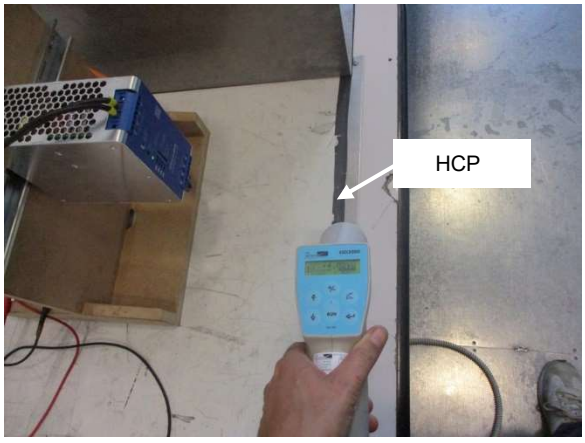
EUT port[1]	Test n° [2]	Supply Voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
0	1	1	A	A	1	1	P

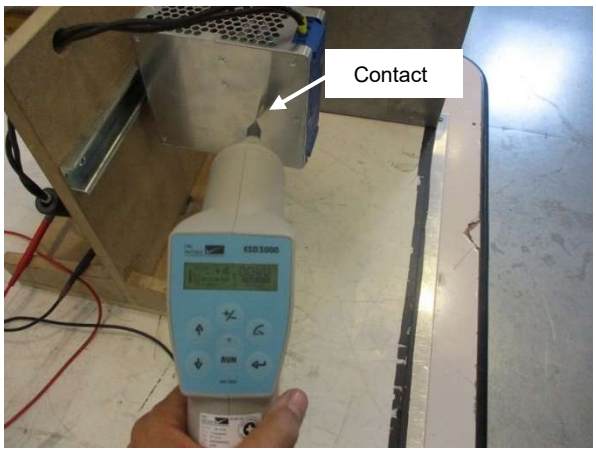
Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See test specification clause reported below for this test
[3] See clause 4.2 EUT Power Supply
[4] For criterion definition and requirement see clause 5 Performance Levels

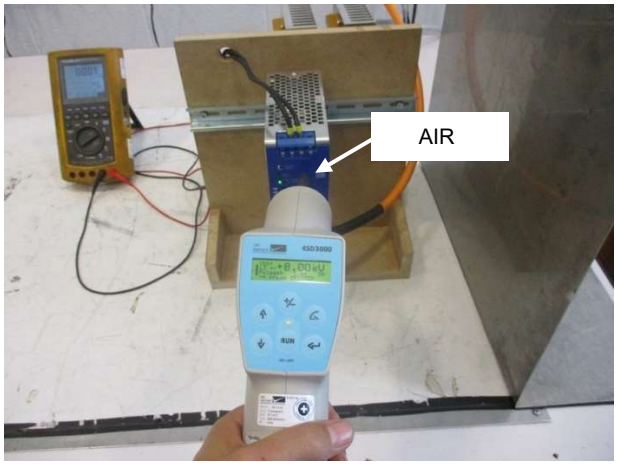
6.6.2 Photo documentation of the test set-up











6.6.3 Test method

Method standard is reported at par. 3.2. The test is intended to demonstrate the immunity of equipment subjected to static electricity discharges from operators directly and to adjacent objects. The table-top equipment under test is placed on a wooden table, 0.8 m high, standing on the ground reference plane. A horizontal coupling plane (HCP) is placed on the table. The EUT and the cables are isolated from the coupling plane by an insulating support 0.5 mm thick. The floor standing equipment is isolated from the ground reference plane by an insulating support about 0.1 m thick. The vertical coupling plane (VCP) of dimensions 0.5 m x 0.5 m is placed parallel to, and positioned at a distance of 0.1 m from, the EUT. Air discharges are applied to non-metallic parts of the system. Contact discharges are applied to all accessible metallic parts. Discharges are also applied to the Horizontal and Vertical Coupling Planes.

6.6.4 Test specification

Test n°	Discharge type	Discharge impedance	Discharge repetition	Discharge polarity	Test level
1	contact	330 Ω / 150 pF	10 discharges, one per second	positive and negative	4 kV
2	air	330 Ω / 150 pF	10 discharges, one per second	positive and negative	8 kV
Notes:					

6.6.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☒	ESD Test system	EMC Partner	ESD3000	252 + 192
☐	ESD Test system	Teseq	NSG437	767+437767

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

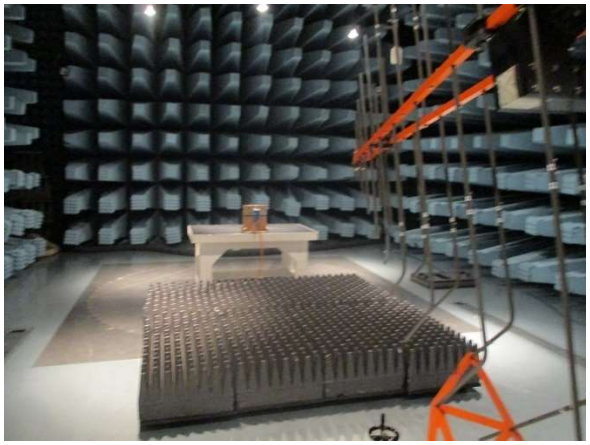
6.7 Radio-frequency electromagnetic field. Amplitude modulated

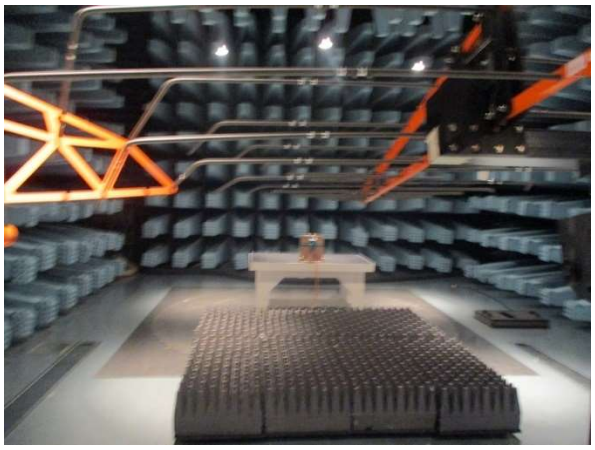
6.7.1 Test result

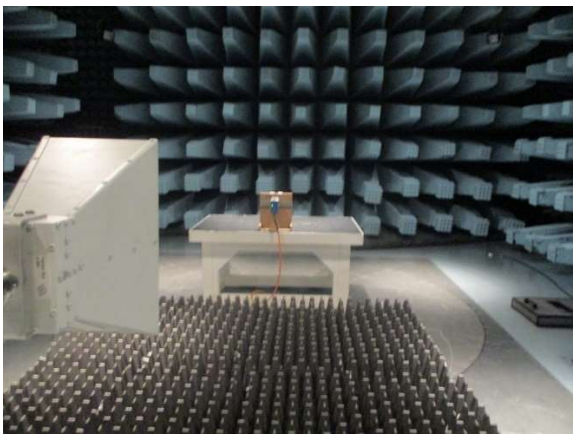
EUT port[1]	Test n° [2]	Supply voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
0	1, 2	1	A	A	1	1	P

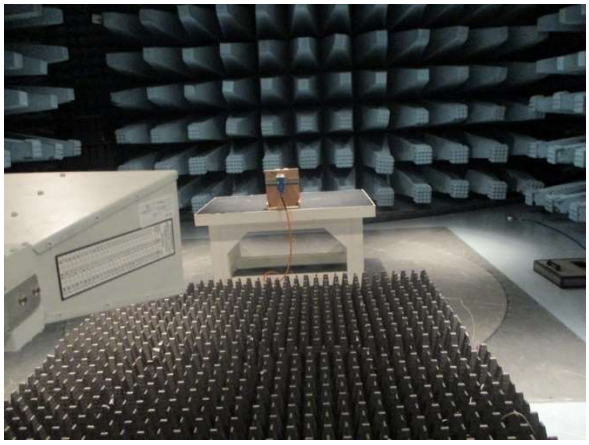
Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See test specification clause reported below for this test
[3] See clause 4.2 EUT Power Supply
[4] For criterion definition and requirement see clause 5 Performance Levels

6.7.2 Photo documentation of the test set-up









6.7.3 Test method

Method standard is reported at par. 3.2. The test allows estimating of the radiated immunity of electrical and electronic equipment to electromagnetic disturbances coming from intended radio-frequency (RF) transmitters

in the frequency range indicated in the product standard. The interference is applied on the enclosure of the equipment by using transmitting antennas. Measurements are made in a fully anechoic chamber and the indicated field strength is pre-calibrated prior to placement of the system under test.

6.7.4 Test specification

Test n°	EUT - Antenna separation	Frequency step	Modulation	Frequency range	Test level
1[1]	2.5 m ± 0.3 m	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	80 MHz to 1000 MHz	10 V/m
2[1]	2.5 m ± 0.3 m	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	1.4 GHz to 6 GHz	3 V/m

Notes:

[1] Test was performed with antenna in both horizontal and vertical polarization, positioning each EUT face in front of generating antenna. Top and bottom faces are not exposed to EM field for table-top and floor standing equipment.

6.7.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
	RF Amplifier	Amplifier Research	1000A225	336745
	RF amplifier	Amplifier Research	50S1G4A	301049
	Log periodic antenna	Amplifier Research	AT6026A	330878
	Bidirectional coaxial coupler	Amplifier Research	DC7144	301249
☒	RF Amplifier	IFI	CMX100010-SMCC1000	L448A-0108
	SAC	Nemko Spa	10m SAC	530
	Power sensor	Rohde & Schwarz	NRP18AN	100987
	RF generator	Rohde & Schwarz	SMB100A	180431
	Shielded room	Siemens	10m control room	1947
	Biconilog antenna	ETS Lindgren	3142E	00213197
	Turntable	Inn.co	CT1000-150kg	CT1000/115/40 530517/P
	SAC	Nemko	3m SAC	70
☐	RF amplifier	Rohde & Schwarz	BBA100	101163
	RF amplifier	Rohde & Schwarz	BBA150	102626
	Power sensor	Rohde & Schwarz	NRP18AN	100987
	RF generator	Rohde & Schwarz	SMA100B	104075
	Shielded room	Siemens	3 m control room	3
☒	Broad-Band Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA9120D	01874

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.8 Fast transients

6.8.1 Test result

EUT port[1]	Test n° [2]	Supply voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
1	1	1	B	B[5]	1	1	P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See test specification clause reported below for this test
[3] See clause 4.2 EUT Power Supply
[4] For criterion definition and requirement see clause 5 Performance Levels
[5] They are some very slight current drops

6.8.2 Photo documentation of the test set-up

6.8.3 Test method

Method standard is reported at par. 3.2. The test is intended to demonstrate the immunity of equipment subjected to types of transient disturbances such as those originating from switching transients (interruption of inductive loads, relay contact bounce….). The bursts are applied on the mains supply port by using a coupling decoupling network and on signal and control lines ports by using a capacitive clamp. Measurements are made on a ground plane.

6.8.4 Test specification

Test n°	Port type	Coupling device	Burst repetition frequency	Burst polarity	Test duration	Test level
1	I/O AC power ports	network	5 kHz or 100 kHz [1]	positive and negative	60 s	2 kV
2[2]	I/O DC power ports	network	5 kHz or 100 kHz [1]	positive and negative	60 s	1 kV
3[2]	Signal/control ports	clamp	5 kHz or 100 kHz [1]	positive and negative	60 s	1 kV

Notes:

[1] The test may be performed at one or at both repetition frequencies. The use of 5 kHz repetition frequency is traditional; however, 100 kHz is closer to reality.

[2] Applicable only to ports interfacing with cables whose total length according to the manufacturer's functional specification may exceed 3 m. Not applicable to input ports intended for connection to a battery or a rechargeable battery which shall be removed or disconnected from the equipment for recharging.

6.8.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☒	Pulse generator	EMC partner	IMU3000	F5-S-D-V-1505
	Coupling network	EMC partner	CDN2000-06-32	1537
☐	Pulse generator	EMC partner	Transient 2000	849
	Coupling network	Schaffner	CDN 300	231
☒	Coupling clamp	EMC partner	CN-EFT1000	120
☒	Coupling clamp	Schaffner	CDN 125	245 9219

Notes:

[1] See clause 1.7 for calibration information.

[2] If crossed, the instrument was used during tests.

6.9 Surges

6.9.1 Test result

EUT port[1]	Test n° [2]	Supply voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
1	1, 2	1	B	A	1	1	P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See test specification clause reported below for this test
[3] See clause 4.2 EUT Power Supply
[4] For criterion definition and requirement see clause 5 Performance Levels

6.9.2 Photo documentation of the test set-up

6.9.3 Test method

Method standard is reported at par. 3.2. The test allows estimating of the conducted immunity of electrical and electronic equipment to unidirectional surges caused by over voltages from switching and lighting transients. The interference is applied on symmetrical and unsymmetrical modes on mains supply port by using coupling decoupling network. Five positive surges and five negative surges are applied at each of phases of the a.c. waveform: 0°, 90°, 180° and 270°. Each surge was applied 60 seconds after the previous surge. Signal and Telecommunications ports were subject to five positive and five negative surges applied through the appropriate Coupling/Decoupling Network (CDN).

6.9.4 Test specification

Test N°	Port type	Coupling type	Coupling network	Pulse type	Pulse polarity	Pulse repetition	Test level
1[1]	I/O AC power ports	line to line	2 Ω + 18 µF	1.2 / 50 µs	positive and negative	5 surges, one per minute	2 kV
2[1]	I/O AC power ports	line to earth	12 Ω + 9 µF	1.2 / 50 µs	positive and negative	5 surges, one per minute	4 kV
3[2]	I/O DC power ports	line to line	2 Ω + 18 µF	1.2 /50 µs	positive and negative	5 surges, one per minute	0.5 kV
4[2]	I/O DC power ports	line to earth	12 Ω + 9 µF	1.2 /50 µs	positive and negative	5 surges, one per minute	1 kV
5[2]	Signal/control ports	line to earth	42 Ω + 0.5 µF	1.2 /50 µs	positive and negative	5 surges, one per minute	1 kV

Notes:
[1] Test repeated at phase angle 0°, 90°, 180° and 270°
[2] Applicable only to ports interfacing with long distance lines; not applicable to input ports intended for connection to a battery or a rechargeable battery which shall be removed or disconnected from the equipment for recharging.

6.9.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☒	Pulse generator	EMC partner	IMU3000	F5-S-D-V-1505
	Coupling network	EMC partner	CDN2000-06-32	1537
	Coupling network	EMC partner	CDN-UTP ED3	1526
☐	Pulse generator	EMC partner	Transient 2000	849
	Coupling network	Schaffner	CDN 116	149 9318

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

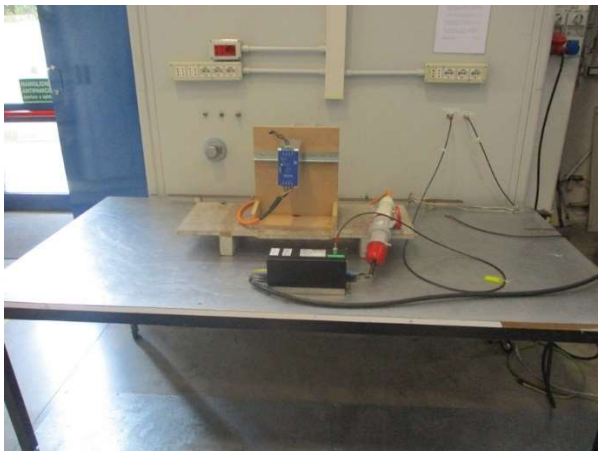
6.10 Radio-frequency common mode

6.10.1 Test result

EUT port[1]	Test n° [2]	Supply voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
1	4	1	A	A	1	1	P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See test specification clause reported below for this test
[3] See clause 4.2 EUT Power Supply
[4] For criterion definition and requirement see clause 5 Performance Levels

6.10.2 Photo documentation of the test set-up



6.10.3 Test method

Method standard is reported at par. 3.2. The test allows estimating of the conducted immunity of electrical and electronic equipment to electromagnetic disturbances coming from intended radio-frequency (RF) transmitters in the frequency range 150 kHz to 80 MHz. The interference is applied on mains supply, signal line and earth connection ports by using coupling decoupling networks or a clamp. Measurements are made on a ground plane. The EUT was located 10cm above the reference ground plane and any associated I/O cables attached to the EUT are located between 30mm and 50mm above the ground plane. The indicated field is pre-calibrated prior to placement of the system under test.

6.10.4 Test specification

Test n°	Port type	Coupling Device	Frequency step	Modulation	Frequency range	Test level
1	I/O AC power ports	CDN M2	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
2	I/O AC power ports	CDN M3	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
3	I/O AC power ports	CDN M4	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
4	I/O AC power ports	CDN M5	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
5[1]	I/O DC power ports	CDN M2	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
6[1]	I/O DC power ports	CDN M3	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
7[1]	Signal/control ports	CLAMP	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
8[1]	Signal/control ports	AF2	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
9[1]	Signal/control ports	T2	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V
10[1]	Signal/control ports	S1	1 % with 3 s dwell time	80 % AM modulated with a 1 kHz sine wave	0.15 to 80 MHz	10 V

Notes:

[1] Applicable only to ports interfacing with cables whose total length according to the manufacturer's functional specification may exceed 3 m.

6.10.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☒	RF Conducted immunity test equipment	Teseq-Ametek	NSG4070C-80	540125
☐	RF Conducted immunity test equipment	EM Test	CWS500 CSI	V0710102305
☒	Attenuator 6dB	EM Test	ATT6/75	0206-18
☐	EM injection clamp	FCC	F-203I-23mm	121239
☐	Bulk current injection probe	FCC	F-120-9A	447
☐	CDN	EM Test	CDN M2 / M3	0307-16
☐	CDN	Luthi	CDN M2/M3	P1426135614
☐	CDN	Luthi	CDN M4 N-32A	P1343125190
☒	CDN	Luthi	CDN M4 PE-32A	P1428136828
☐	CDN	Luthi	CDN M5-32A	P1430137446
☐	CDN	Luthi	CDN S1-50 BNC	P1430137436
☐	CDN	Luthi	CDN T2	P1427136163
☐	CDN	Luthi	CDN AF2	P1425135039

Notes:
[1] See clause 1.7 for calibration information.
[2] If crossed, the instrument was used during tests.

6.11 Power frequency magnetic field

6.11.1 Test result

EUT port[1]	Test n° [2]	Supply voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
0	1	1	A	A	1	1	P

Notes:
[1] See clause 4.6 EUT Input/Output Ports
[2] See test specification clause reported below for this test
[3] See clause 4.2 EUT Power Supply
[4] For criterion definition and requirement see clause 5 Performance Levels

6.11.2 Photo documentation of the test set-up

6.11.3 Test method

Method standard is reported at par. 3.2. This test is intended to demonstrate the immunity of equipment when subjected to power frequency magnetic fields. The test magnetic field is obtained by a current flowing in an induction coil; the application of the test field to the EUT is by the immersion method.

6.11.4 Test specification

Test n°	Magnetic field type	Magnetic field orientation[1]	Test duration	Test frequency	Test level
1[2]	sinusoidal continuous filed	x-axis, y-axis, z-axis	60 s	50 Hz	30 A/m
2[2]	sinusoidal continuous filed	x-axis, y-axis, z-axis	60 s	60 Hz	30 A/m

Notes:

[1] Respect to EUT

[2] Applicable only to equipment containing devices susceptible to magnetic fields. The test shall be carried out at the frequencies appropriate to the power supply frequency. Equipment intended for use in areas supplied only at one of these frequencies need only be tested at that frequency.

6.11.5 Test equipment used[1]

Used [2]	Description	Manufacturer	Model	Identifier
☒	Magnetic field meter	Maschek	ESM-100	971909-G
☒	Helmotz induction coil	G.I.E.	IEC1000-4-8	111962

Notes:

[1] See clause 1.7 for calibration information.

[2] If crossed, the instrument was used during tests.

6.12 Voltage dips and interruptions

6.12.1 Test result

EUT port[1]	Test n° [2]	Supply voltage[3]	Criterion[4]		Mode		Verdict
			Required	Achieved	Operation	Configuration	
1	1	1	A	A	1	1	P
1	3	1	C	B[6]	1	1	P
1	5	1	C	A	1	1	P
1	7	1	C	C[7]	1	1	P

Notes:

[1] See clause 4.6 EUT Input/Output Ports

[2] See test specification clause reported below for this test

[3] See clause 4.2 EUT Power Supply

[4] For criterion definition and requirement see clause 5 Performance Levels

[5] If this note is present near the verdict P, it means that he EUT does not demonstrate compliance when tested with 0 degree switching; the test was repeated with the switching occurring at both 90 degrees and 270 degrees and EUT fulfilled the requirements.

[6] They are some very slight current drops

[7] Power supply turns off. At the end of the test it returns autonomously in normal working condition

6.12.2 Photo documentation of the test set-up

6.12.3 Test method

Method standard is reported at par. 3.2. The test allows estimating of the conducted immunity of electrical and electronic equipment connected to low-voltage power supply networks for voltage dips and short interruptions. Testing is performed with the product connected directly to a generator capable of simulating the voltage drops and interrupts as described.

6.12.4 Test specification

Test n°	Change type	Frequency	Cycles	Test level[3]
1	Voltage dips	50 Hz	1	0 %
2	Voltage dips	60 Hz	1	0 %
3	Voltage dips	50 Hz	10	40 %
4	Voltage dips	60 Hz	12	40 %
5	Voltage dips	50 Hz	25	70 %
6	Voltage dips	60 Hz	30	70 %
7	Voltage interruptions	50 Hz	250	0 %
8	Voltage interruptions	60 Hz	300	0 %

Notes:

[1] Changes to occur at 0 degree crossover point of the voltage waveform.

[2] The test shall be carried out at the frequencies appropriate to the power supply frequency. Equipment intended to be used in regions where only one of these frequencies is applied needs to be tested at this specific frequency only.

[3] % residual voltage

6.12.5 Test equipment used[1]

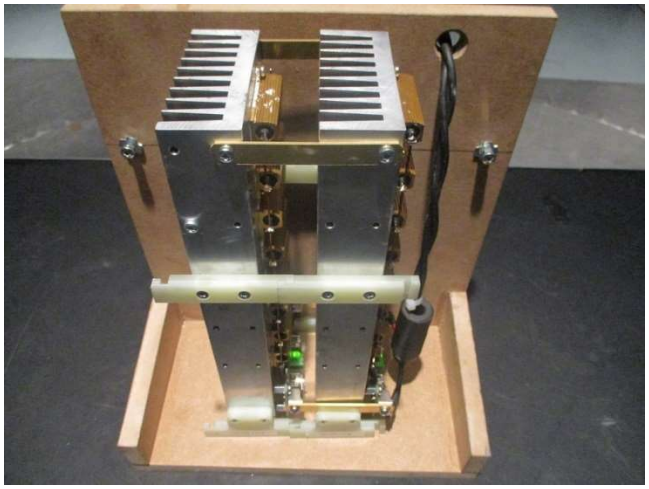
Used [2]	Description	Manufacturer	Model	Identifier
☒	Pulse generator	EMC partner	IMU3000	F5-S-D-V-1505
☐	Pulse generator	EMC partner	Transient 2000	849
☐	Power supply	Zenone	GVS300GL	0000000446
☐	Power supply	Zenone	GVS300GL	0000000445
☐	Power supply	Zenone	GVS300GL	0000000444

Notes:

[1] See clause 1.7 for calibration information.

[2] If crossed, the instrument was used during tests.

7 EUT PHOTOS



Auxiliary Equipment – Resistance load

End of report